

Search Notes

Application/Control No.

10/669,805

Examiner

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Applicant(s)/Patent under
Reexamination

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Art Unit

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SEARCHED

Class	Subclass	Date	Examiner
710	22-28,52-56	6/13/2007	CS
711	202-209	6/13/2007	CS

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
710	22,56	11/12/2007	CS
711	208	11/12/2007	CS

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
PLUS	6/13/2007	CS
PALM for double patenting	6/13/2007	CS
EAST (USPGPUB,USPAT,USOCR,FPRS,E PO,JPO,DERWENT,IBMTDB)	6/13/2007	CS